

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/584,314 | | Applicant(s)/Patent Under Reexamination HAYAKAWA ET AL. | |
| | Examiner Marcus Charles | | Art Unit 3656 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,340,854 B1 | 01-2002 | Jeong, Dae Hyun | 310/90 |
| * | B | US-2003/0113045 A1 | 06-2003 | Fujinaka, Hiroyasu | 384/114 |
| * | C | US-6,609,829 B2 | 08-2003 | Saito et al. | 384/100 |
| * | D | US-2004/0032175 A1 | 02-2004 | Grantz et al. | 310/90 |
| * | E | US-6,817,766 B2 | 11-2004 | Gomyo, Masato | 384/132 |
| * | F | US-6,900,568 B2 | 05-2005 | LeBlanc et al. | 384/119 |
| * | G | US-6,939,046 B2 | 09-2005 | Oelsch, Juergen | 384/107 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | I | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.